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- Bidirectional Transceivers
- Meet or Exceed the Requirements of ANSI Standards EIA/TIA-422-B and RS-485 and ITU Recommendations V.11 and X.27
- Designed for Multipoint Transmission on Long Bus Lines in Noisy Environments
- 3-State Driver and Receiver Outputs
- Individual Driver and Receiver Enables
- Wide Positive and Negative Input/Output Bus Voltage Ranges
- Driver Output Capability . . . ±60 mA Max
- Thermal Shutdown Protection
- Driver Positive and Negative Current Limiting
- Receiver Input Impedance . . . 12 kΩ Min
- Receiver Input Sensitivity . . . ± 200 mV
- Receiver Input Hysteresis . . . 50 mV Typ
- Operate From Single 5-V Supply

D OR P PACKAGE (TOP VIEW) R 1 8 V_{CC} RE 2 7 B DE 3 6 A D 4 5 GND

description

The SN65176B and SN75176B differential bus transceivers are monolithic integrated circuits designed for bidirectional data communication on multipoint bus transmission lines. They are designed for balanced transmission lines and meet ANSI Standards EIA/TIA-422-B and RS-485 and ITU Recommendations V.11 and X.27.

The SN65176B and SN75176B combine a 3-state differential line driver and a differential input line receiver, both of which operate from a single 5-V power supply. The driver and receiver have active-high and active-low enables, respectively, that can be externally connected together to function as a direction control. The driver differential outputs and the receiver differential inputs are connected internally to form differential input/output (I/O) bus ports that are designed to offer minimum loading to the bus whenever the driver is disabled or $V_{\rm CC}=0$. These ports feature wide positive and negative common-mode voltage ranges making the device suitable for party-line applications.

The driver is designed for up to 60 mA of sink or source current. The driver features positive- and negative-current limiting and thermal shutdown for protection from line-fault conditions. Thermal shutdown is designed to occur at a junction temperature of approximately 150°C. The receiver features a minimum input impedance of 12 k Ω , an input sensitivity of ± 200 mV, and a typical input hysteresis of 50 mV.

The SN65176B and SN75176B can be used in transmission line applications employing the SN75172 and SN75174 quadruple differential line drivers and SN75173 and SN75175 quadruple differential line receivers.

The SN65176B is characterized for operation from -40° C to 105° C and the SN75176B is characterized for operation from 0° C to 70° C.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



Function Tables

DRIVER

INPUT	NPUT ENABLE		PUTS
D	DE	Α	В
Н	Н	Н	L
L	Н	L	Н
X	L	Z	Z

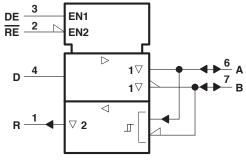
RECEIVER

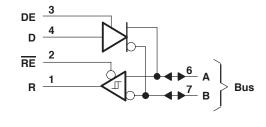
DIFFERENTIAL INPUTS A – B	ENABLE RE	OUTPUT R
V _{ID} ≥ 0.2 V	L	Н
$-0.2 \text{ V} < \text{V}_{\text{ID}} < 0.2 \text{ V}$	L	?
$V_{ID} \leq -0.2 V$	L	L
Х	Н	Z
Open	L	Н

H = high level, L = low level, ? = indeterminate,

logic symbol†

logic diagram (positive logic)

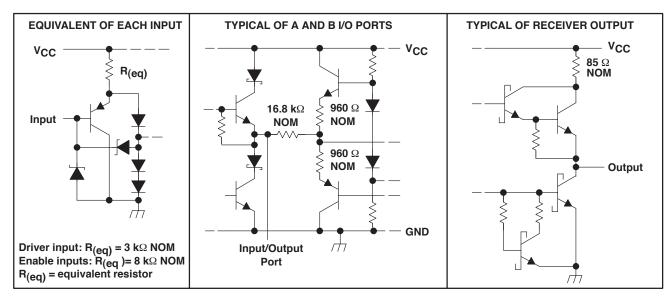




X = irrelevant, Z = high impedance (off)

[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

schematics of inputs and outputs



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V _{CC} (see Note 1)	7 V
Voltage range at any bus terminal	
Enable input voltage, V ₁	5.5 V
Continuous total power dissipation	. See Dissipation Rating Table
Operating free-air temperature range, T _A : SN65176B	40°C to 105°C
SN75176B	0°C to 70°C
Storage temperature range, T _{stq}	– 65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltage values, except differential input/output bus voltage, are with respect to network ground terminal.

DISSIPATION RATING TABLE

	PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 105°C POWER RATING
Г	D	725 mW	5.8 mW/°C	464 mW	261 mW
	Р	1100 mW	8.8 mW/°C	704 mW	396 mW

SN65176B, SN75176B DIFFERENTIAL BUS TRANSCEIVERS

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recommended operating conditions

			MIN	TYP	MAX	UNIT
Supply voltage, V _{CC}			4.75	5	5.25	V
Voltago at any bue terminal (congrate)	oltage at any bus terminal (separately or common mode), V _I or V _{IC}				12	V
ontage at any bus terminal (separately or common mode), v or v C				-7	V	
High-level input voltage, VIH	D, DE, and RE		2			V
Low-level input voltage, V _{IL}	D, DE, and RE				0.8	V
Differential input voltage, V _{ID} (see Note 2)				±12	V	
I find to the standard and the standard	Driver				-60	mA
High-level output current, IOH	Receiver				-400	μΑ
Low-level output current, IOI	Driver				60	mA
Low-level output current, IOL	Receiver				8	IIIA
Operating free-air temperature, TA	SN65176B		-40		105	°C
Operating nee-an temperature, 1A	SN75176B	•	0		70	

NOTE 2: Differential-input/output bus voltage is measured at the noninverting terminal A with respect to the inverting terminal B.



DRIVER SECTION

electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER		TEST CONDITIONS†		MIN	TYP‡	MAX	UNIT	
VIK	Input clamp voltage	I _I = –18 mA				-1.5	V	
VO	Output voltage	IO = 0		0		6	V	
IV _{OD1} I	Differential output voltage	I _O = 0		1.5	3.6	6	V	
IV _{OD2} I	Differential output voltage	R _L = 100 Ω,	See Figure 1	1/2 V _{OD1} or 2¶			V	
		$R_L = 54 \Omega$, See Figure 1		1.5	2.5	5	V	
V _{OD3}	Differential output voltage	See Note 4		1.5		5	V	
ΔΙV _{OD} Ι	Change in magnitude of differential output voltage§					±0.2	٧	
Voc	Common-mode output voltage	R_L = 54 Ω or 100 Ω , See Figure 1				+3 -1	٧	
ΔΙV _{OC} Ι	Change in magnitude of common-mode output voltage§					±0.2	٧	
lo.	Output current	Output disabled,	V _O = 12 V			1	mA	
Ю	Output current	See Note 3	$V_{O} = -7 \text{ V}$			-0.8	IIIA	
lн	High-level input current	V _I = 2.4 V				20	μΑ	
I _I L	Low-level input current	V _I = 0.4 V				-400	μΑ	
		V _O = -7 V				-250		
	Chart aireuit autaut aurrent	V _O = 0				150	A	
los	Short-circuit output current	$V_O = V_{CC}$				250	mA	
		V _O = 12 V				250		
loo	Supply surrent (total poskegs)	No load	Outputs enabled		42	70		
Icc	Supply current (total package)	INO IOAU	Outputs disabled		26	35	mA	

The power-off measurement in ANSI Standard EIA/TIA-422-B applies to disabled outputs only and is not applied to combined inputs and outputs. \ddagger All typical values are at $V_{CC} = 5$ V and $T_A = 25$ °C.

NOTES: 3. See ANSI Standard RS-485 Figure 3.5, Test Termination Measurement 2.

switching characteristics, V_{CC} = 5 V, R_L = 110 k Ω , T_A = 25°C (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
t _d (OD)	Differential-output delay time	Pr = 54 O Soo Fig	uro 3		15	22	ns
t _{t(OD)}	Differential-output transition time	$R_L = 54 \Omega$, See Figure 3			20	30	ns
^t PZH	Output enable time to high level	See Figure 4			85	120	ns
tPZL	Output enable time to low level	See Figure 5			40	60	ns
^t PHZ	Output disable time from high level	See Figure 4			150	250	ns
tPLZ	Output disable time from low level	See Figure 5	·		20	30	ns

[§] ΔIV_{OD}I and ΔIV_{OC}I are the changes in magnitude of V_{OD} and V_{OC}, respectively, that occur when the input is changed from a high level to a low level.

 $[\]P$ The minimum $V_{\mbox{OD2}}$ with a 100- $\!\Omega$ load is either 1/2 $V_{\mbox{OD1}}$ or 2 V, whichever is greater.

^{4.} This applies for both power on and off; refer to ANSI Standard RS-485 for exact conditions. The EIA/TIA-422-B limit does not apply for a combined driver and receiver terminal.

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SYMBOL EQUIVALENTS

DATA-SHEET PARAMETER	EIA/TIA-422-B	RS-485
V _O	V_{oa}, V_{ob}	V _{oa,} V _{ob}
IV _{OD1} I	V _O	V _O
IV _{OD2} I	$V_t (R_L = 100 \Omega)$	$V_t (R_L = 54 \Omega)$
IV _{OD3} I		V _t (Test Termination Measurement 2)
ΔIV _{OD} I	I IV _t I − I V tI I	I IV _t −I V tI I
V _{OC}	IV _{os} I	IV _{OS} I
ΔΙVOCΙ	$ V_{OS} - \overline{V}_{OS} $	$ V_{OS} - \overline{V}_{OS} $
los	II _{sa} I, II _{sb} I	
lo	II _{xa} I, II _{xb} I	I _{ia} , I _{ib}

RECEIVER SECTION

electrical characteristics over recommended ranges of common-mode input voltage, supply voltage, and operating free-air temperature (unless otherwise noted)

PARAMETER TEST C		TEST CO	NDITIONS	MIN	TYP	MAX	UNIT
V _{IT+}	Positive-going input threshold voltage	$V_0 = 2.7 V$,	$I_{O} = -0.4 \text{ mA}$			0.2	V
V _{IT} _	Negative-going input threshold voltage	$V_O = 0.5 V$,	I _O = 8 mA	-0.2‡			V
V _{hys}	Input hysteresis voltage (V _{IT+} - V _{IT-})				50		mV
VIK	Enable Input clamp voltage	I _I = -18 mA				-1.5	V
VOH	High-level output voltage	V _{ID} = 200 mV, See Figure 2	$I_{OH} = -400 \mu A,$	2.7			٧
V _{OL}	Low-level output voltage	V _{ID} = -200 mV, See Figure 2	I _{OL} = 8 mA,			0.45	٧
loz	High-impedance-state output current	V _O = 0.4 V to 2.4 V				±20	μΑ
1.	Line input current	Other input = 0 V, V _I = 12 V	V _I = 12 V			1	mA
1	Line input current	See Note 5	$V_I = -7 V$			-0.8	IIIA
ΊΗ	High-level enable input current	V _{IH} = 2.7 V				20	μΑ
I _{IL}	Low-level enable input current	V _{IL} = 0.4 V				-100	μΑ
rį	Input resistance	V _I = 12 V		12			kΩ
los	Short-circuit output current			-15		-85	mA
1	Cumply augment (total poolsons)	Najaad	Outputs enabled		42	55	A
ICC	Supply current (total package)	No load	Outputs disabled		26	35	mA

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

NOTE 5: This applies for both power on and power off. Refer to EIA Standard RS-485 for exact conditions.

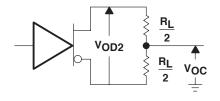


[‡] The algebraic convention, in which the less positive (more negative) limit is designated minimum, is used in this data sheet for common-mode input voltage and threshold voltage levels only.

switching characteristics, V_{CC} = 5 V, C_L = 15 pF, T_A = 25°C

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
^t PLH	Propagation delay time, low- to high-level output	V.= - 0 to 2 V Soo Figure 6		21	35	ns
t _{PHL}	Propagation delay time, high- to low-level output	V _{ID} = 0 to 3 V, See Figure 6		23	35	ns
^t PZH	Output enable time to high level	See Figure 7		10	20	ns
tPZL	Output enable time to low level	See Figure 7		12	20	ns
^t PHZ	Output disable time from high level	See Figure 7		20	35	ns
t _{PLZ}	Output disable time from low level	See Figure 7		17	25	ns

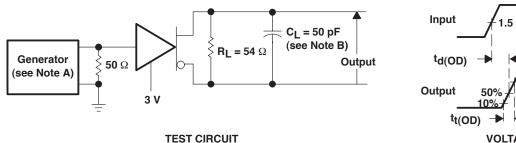
PARAMETER MEASUREMENT INFORMATION

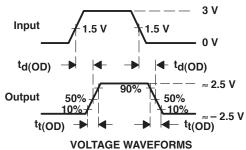


V_{ID} +I_{OL} -I_{OH}

Figure 1. Driver V_{OD} and V_{OC}

Figure 2. Receiver $V_{\mbox{OH}}$ and $V_{\mbox{OL}}$



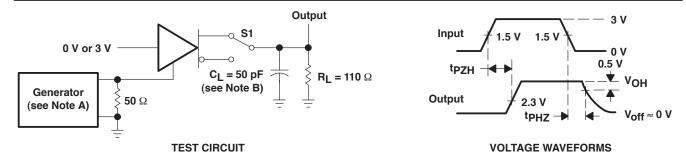


NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 1 MHz, 50% duty cycle, $t_f \leq$ 6 ns, $t_f \leq$ 8 ns, t_f

B. C_L includes probe and jig capacitance.

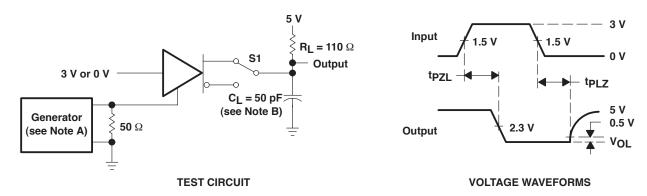
Figure 3. Driver Test Circuit and Voltage Waveforms

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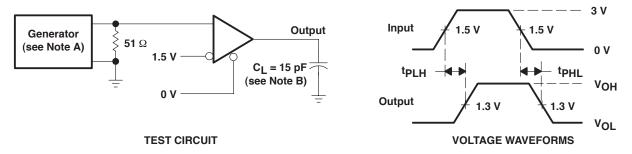
- NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 1 MHz, 50% duty cycle, $t_f \leq$ 6 ns, $t_f \leq$ 6 ns, $Z_O = 50 \Omega$.
 - B. C_L includes probe and jig capacitance.

Figure 4. Driver Test Circuit and Voltage Waveforms



- NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 1 MHz, 50% duty cycle, $t_r \leq$ 6 ns, $t_f \leq$ 6 ns, $Z_{\Omega} = 50 \ \Omega$.
 - B. C_L includes probe and jig capacitance.

Figure 5. Driver Test Circuit and Voltage Waveforms

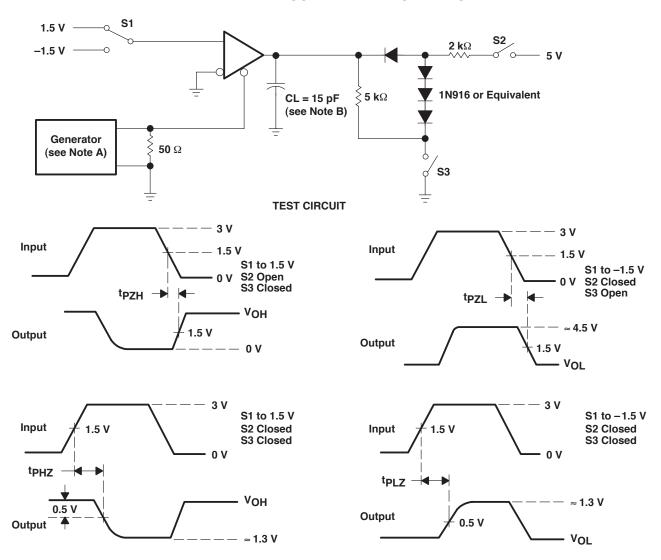


- NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 1 MHz, 50% duty cycle, $t_f \leq$ 6 ns, $t_f \leq$ 6 ns, $Z_O = 50 \Omega$.
 - B. C_I includes probe and jig capacitance.

Figure 6. Receiver Test Circuit and Voltage Waveforms



PARAMETER MEASUREMENT INFORMATION



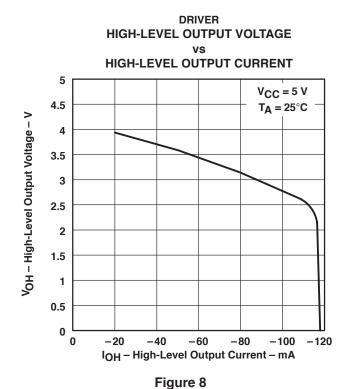
VOLTAGE WAVEFORMS

NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR \le 1 MHz, 50% duty cycle, $t_f \le$ 6 ns, $t_f \le$ 7 ns, $t_f \le$ 8 ns, $t_f \le$ 8 ns, $t_f \le$ 9 ns, $t_f \ge$ 9 ns, t_f

B. CL includes probe and jig capacitance.

Figure 7. Receiver Test Circuit and Voltage Waveforms

TYPICAL CHARACTERISTICS



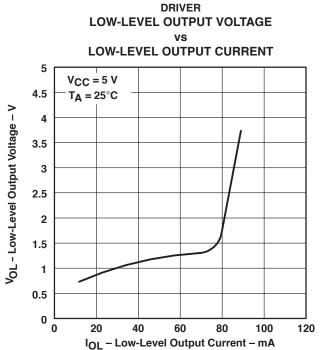


Figure 9

gure o

DRIVER DIFFERENTIAL OUTPUT VOLTAGE

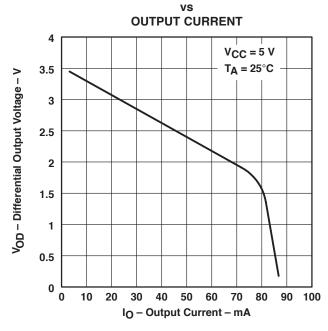


Figure 10



TYPICAL CHARACTERISTICS

RECEIVER HIGH-LEVEL OUTPUT VOLTAGE **HIGH-LEVEL OUTPUT CURRENT** 5 $V_{ID} = 0.2 V$ 4.5 T_A = 25°C VOH - High-Level Output Voltage - V 4 3.5 3 2.5 V_{CC} = 5.25 V 2 $V_{CC} = 5 V$ 1.5 $V_{CC} = 4.75 V$ 1 0.5 0 -10 -15 -20 -25 -30 -35 -40 -45 -50

Figure 11

IOH - High-Level Output Current - mA

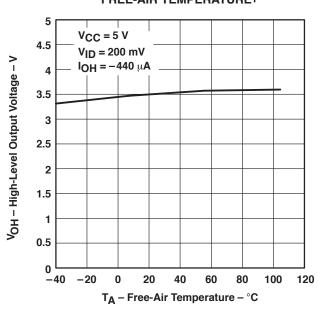
RECEIVER

LOW-LEVEL OUTPUT VOLTAGE

LOW-LEVEL OUTPUT CURRENT 0.6 $V_{CC} = 5 V$ $T_A = 25^{\circ}C$ VOL - Low-Level Output Voltage - V 0.5 0.4 0.3 0.2 0.1 0 0 5 10 15 20 25 30 IOL - Low-Level Output Current - mA

Figure 13

RECEIVER HIGH-LEVEL OUTPUT VOLTAGE vs FREE-AIR TEMPERATURE†



 † Only the 0°C to 70°C portion of the curve applies to the SN75176B.

Figure 12

RECEIVER LOW-LEVEL OUTPUT VOLTAGE vs FREE-AIR TEMPERATURE

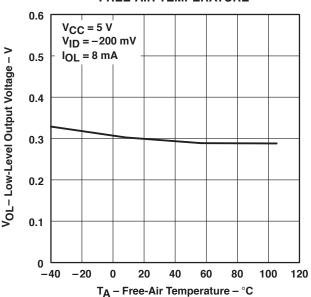
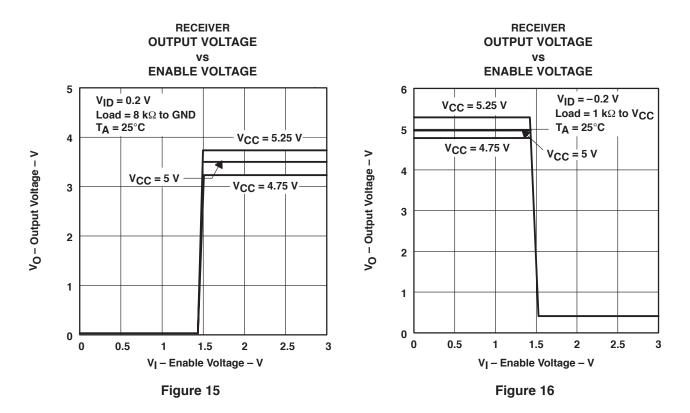
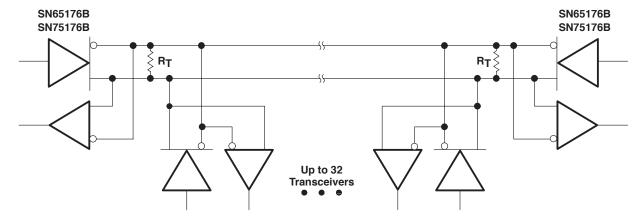


Figure 14

TYPICAL CHARACTERISTICS



APPLICATION INFORMATION



NOTES: A. The line should be terminated at both ends in its characteristic impedance ($R_T = Z_O$). Stub lengths off the main line should be kept as short as possible.

Figure 17. Typical Application Circuit



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